Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/658,839	YU ET AL.	
Examiner	Art Unit	
Y Lee	2621	

	SEAR	CHED	
Class	Subclass	Date	Examiner
375	240.01 240.16 240.24 240.26	7/16/2007	YL
348	208.99		
H04N	7/12		
update	search	1/28/2008	YL
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INTERFERENCE SEARCHED			
Subclass	Date	Examiner	
240.16	1/29/2008	YL	
1			
		171	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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